Disorder Imposed Limits of Mono- and Bilayer Graphene Electronic Modification Using Covalent Chemistry

Chih-Jen Shih,† Qing Hua Wang,† Zhong Jin,† Geraldine L. C. Paulus,† Daniel Blankschtein,† Pablo Jarillo-Herrero,‡ and Michael S. Strano*†

†Department of Chemical Engineering and ‡Department of Physics, Massachusetts Institute of Technology, Cambridge, Massachusetts 02139, United States

Supporting Information

ABSTRACT: A central question in graphene chemistry is to what extent chemical modification can control an electronically accessible band gap in monolayer and bilayer graphene (MLG and BLG). Density functional theory predicts gaps in covalently functionalized graphene as high as 2 eV, while this approach neglects the fact that lattice symmetry breaking occurs over only a prescribed radius of nanometer dimension, which we label the S-region. Therefore, high chemical conversion is central to observing this band gap in transport. We use an electrochemical approach involving phenyl-diazonium salts to systematically probe electronic modification in MLG and BLG with increasing functionalization for the first time, obtaining the highest conversion values to date. We find that both MLG and BLG retain their relatively high conductivity after functionalization even at high conversion, as mobility losses are offset by increases in carrier concentration. For MLG, we find that band gap opening as measured during transport is linearly increased with respect to the $I_D/I_G$ ratio but remains below 0.1 meV in magnitude for SiO$_2$ supported graphene. The largest transport band gap obtained in a suspended, highly functionalized ($I_D/I_G = 4.5$) graphene is about 1 meV, lower than our theoretical predictions considering the quantum interference effect between two neighboring S-regions and attributed to its population with midgap states. On the other hand, heavily functionalized BLG ($I_D/I_G = 1.8$) still retains its signature dual-gated band gap opening due to electric-field symmetry breaking. We find a notable asymmetric deflection of the charge neutrality point (CNP) under positive bias which increases the apparent on/off current ratio by 50%, suggesting that synergy between symmetry breaking, disorder, and quantum interference may allow the observation of new transistor phenomena. These important observations set definitive limits on the extent to which chemical modification can control graphene electronically.

KEYWORDS: Graphene, bilayer graphene, transport band gap, chemical functionalization, disorder

Graphene, with atomic sheets consisting of fewer than 10 stacked layers of sp$^2$-hybridized carbon lattice, has emerged as a promising candidate material for postsilicon nanoelectronics due to its ultrahigh carrier mobility. Recent progress in tuning the band gap and resistivity in AB-stacked bilayer graphene by breaking the symmetry between the top and bottom graphene planes has shed further light on engineering the transport properties of graphene. Nevertheless, for most potential applications, these materials require advanced methods to open a more significant transport band gap without sacrificing their intrinsic mobilities. To enable semiconducting behavior in graphene, various physical approaches have been proposed, including nanoribbons, nanomeshes, and strain engineering. However, these approaches generally involve ultraprecise processing, which remains a significant challenge for mass production.

Several theoretical and empirical studies of covalent graphene chemistry predict its ability to open a controllable band gap in monolayer graphene (MLG) and bilayer graphene (BLG), a longstanding goal of the field. Methods of functionalizing graphene have advanced considerably in recent...
years. Numerous chemical routes, including hydrogenation, oxidation, fluorination, and aryldiazonium chemistry, have been developed. Among these methods, covalent functionalization using aryldiazonium salts occurs by an electron transfer mechanism, where a delocalized electron is transferred from the graphene lattice to an adjacent reactant, forming a radical, which then forms a covalent bond with a graphene carbon atom and therefore grafts onto its surface. The electron transfer chemistry of graphene is directly influenced by the localized fluctuation of Fermi level due to electron–hole puddles induced by charged impurities in the substrate, as well as by the edge disorders. Due to these extrinsic effects, to date, the chemical routes used lack an ability to control the reaction rate in a uniform and efficient manner, particularly for multilayer (>1) graphene.

On the other hand, after covalent functionalization, the sp² lattice is partially distorted and interspersed with sp³ regions. Theoretically, there are two mechanisms underlying the formation of a band gap in covalently functionalized MLG: (i) a large band gap (~1–2 eV) created around the structurally disordered region (the S-region) due to the sp³ hybridization, and (ii) a relatively small band gap (~100 meV) created in the pristine sp² lattice between two neighboring S-regions due to the quantum interference phenomena. Experimentally, an optical band gap up to hundreds of meV has been observed. However, despite this activity, the engineering of such a gap of such magnitude under electronic transport conditions has not been realized. The transport characteristics of functionalized graphene devices often exhibit a strong suppression of carrier mobility, and the resulting transport band gap is either ambiguous or not consistent with the optical band gap. There remains a lack of fundamental understanding of electronic transport in functionalized graphene, including its dependence on the degree of functionalization. Moreover, to the best of our knowledge, the electronic characteristics of covalently functionalized bilayer graphene have never been investigated.

In this report, we develop an efficient method to functionalize graphene using an electrochemical aryldiazonium chemistry to achieve the highest levels of lattice conversion to date for MLG and BLG. We study the transport characteristics of bottom-gated monolayer and dual-gated bilayer graphene field effect transistors (FETs) and measure the transport band gap opened precisely as a function of the degree of chemical functionalization. Accordingly, this work establishes the experimental limits of graphene chemistry for controlling its electronic structure.

Results and Discussion. Electrochemical Aryl Diazonium Chemistry. MLG and BLG FET devices were fabricated using the micromechanical cleavage process to isolate graphene flakes on 300 and 100 nm SiO₂/p-doped Si substrates, respectively. The source and drain contacts were patterned onto the flakes utilizing photolithography, followed by the deposition of Ti/Au contact electrodes. The detailed fabrication process is described in Supplementary Section S1. The transport properties of the pristine MLG and BLG devices were characterized at 14 K. The typical mobility is 8000–16 000 cm²/(V s) and 1000–3000 cm²/(V s) for MLG and BLG devices, respectively. These devices were subsequently functionalized, as shown schematically in Figure 1a. Specifically, an electrochemical functionalization was carried out in an acetonitrile solution with 20 mM nitrobenzene diazonium (4-nitrobenzene diazonium tetrafluoroborate) or bromobenzene diazonium (4-bromobenzene diazonium tetrafluoroborate). The source and drain electrodes were electrically grounded, and a positive voltage V₀ was applied to the solution using a tungsten probe for 30 s. Consequently, aryldiazonium groups were grafted onto graphene surfaces through electron transfer reaction to form bromophenyl (Br-ph) or nitrophenyl (NO₂-ph) functionalized graphene, as shown in Figure 1b. The applied electric field creates an electrical double layer adjacent to the graphene surface, such that the Fermi level of graphene is raised, thereby increasing the rate of electron transfer reaction. Note that the increase in Fermi level in this experiment greatly exceeds the typical value of electron–hole puddle amplitudes in graphene on SiO₂, allowing us to neglect the substrate effect observed previously. The positive V₀ also concentrates the diazonium cations (see Figure 1b) within the double layer to accelerate the reaction. More importantly, because of a more precise control of the Fermi-level position, the reaction rate is expected to be more spatially uniform than that using conventional electron transfer chemistries, although Hersam and Wang have demonstrated that multiaromatic oligomers form on the graphene surface at high chemical conversion, as seen for graphite electrodes as well.

Figure 1. (a) Schematic diagram of the electrochemical aryldiazonium chemistry on a graphene FET device. (b) Schematic of the electron transfer chemistry between graphene and 4-bromobenzene diazonium tetrafluoroborate (top) and 4-nitrobenzene diazonium tetrafluoroborate (bottom) to form covalently functionalized graphene grafted with bromophenyl (Br-ph) and nitrophenyl (NO₂-ph) groups, respectively. (c) Optical microscope image (top) and Raman map of the l/Ic (bottom) of a functionalized MLG device using V₀ = 1 V and grounded source and drain electrodes.

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we ignore oligomer formation because it can only reduce the maximum possible chemical conversion. Before characterization, each graphene device was rinsed with copious amounts of acetonitrile to minimize residual physisorption of diazonium molecules.47 Figure 1c shows a representative functionalized MLG device using $V_{RXN} = 1$ V. Its Raman image of the integrated intensity ratio of the D to G peaks ($I_D/I_G$) is also shown. It is noteworthy that unlike conventional aryl diazonium chemistry, we did not observe a significantly higher degree of functionalization at the edge of graphene, 34,36 implying that the Fermi level increase due to the electric field applied to the solution overwhelms the effect of the edge disorder.

Representative Raman spectra corresponding to various values of $V_{RXN}$ for MLG and BLG are shown in Figure 2a and c, respectively. The spectrum of pristine MLG has two prominent peaks, the G and 2D peaks, located around 1580 cm$^{-1}$ and 2630 cm$^{-1}$, respectively.48 After diazonium functionalization, stronger D ($\sim 1315$ cm$^{-1}$) and D' ($\sim 1615$ cm$^{-1}$) peaks become apparent due to the formation of sp$^3$ hybridization using a higher value of $V_{RXN}$. For each spectrum, each of the four peaks can be well fitted with single Lorentzians.33 The peak parameters from fitting the peaks to Lorentzian functions were extracted, and the scatter plots for the 2D peak position ($\omega_{2D}$) and $I_D/I_G$ as a function of the G peak position ($\omega_G$) are shown in Figure 2b. The dashed line corresponds to the trajectory of increasing n- or p-doping in pristine graphene, which leads to an increase of $\omega_G$.45,46 Interestingly, both pristine and functionalized graphene follow the doping trajectory except the most functionalized ones (see Figure 2b top). In addition, since $\omega_G$ does not increase significantly with $I_D/I_G$, it suggests that covalent functionalization itself does not increase the level of doping (see Figure 2b bottom). The slight upshift of $\omega_G$ in functionalized graphene can be attributed to the physisorption of diazonium cation and oligomers.47

Using the electrochemical aryl diazonium reaction, BLG can be functionalized to a significantly high degree, as shown in Figure 2c. The D, G, D', and 2D peaks of pristine and functionalized BLG can be found around 1320, 1580, 1615, and 2640 cm$^{-1}$, respectively. This level of functionalization for BLG is unprecedented in the literature to date. For the first time, we observe that the D (Figure 2e) and 2D peaks of pristine (Figure 2d top) and covalently functionalized (Figure 2d bottom) BLG are all asymmetric and can be decomposed into four Lorentzians, similar to previous reports of ion bombardment defects in bilayer graphene.49 The four components of the 2D peak (2D$_{1B}$, 2D$_{1A}$, 2D$_{2A}$, and 2D$_{2B}$, see Figure 2c) result from the splitting of the phonon branches in BLG.48,50 The covalent functionalization, which presumably introduces defects in the

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*Figure 2.* Representative Raman spectra (with $\lambda_{EX} = 633$ nm) of NO$_2$-ph functionalized (a) MLG and (c) BLG using different values of $V_{RXN}$. (b) 2D peak position ($\omega_{2D}$, top) and $I_D/I_G$ (bottom) for functionalized MLG as a function of G peak position ($\omega_G$), with doping trajectory adapted from refs 44 and 45. Spectra taken from different samples using different $V_{RXN}$ are presented using different colors. (d) The 2D peaks of a pristine (top) and functionalized (bottom) BLG and the fits of four Lorentzian components. (e) The D peak of a functionalized BLG and the fit of four Lorentzian components.
top graphitic layer only (the layer in contact with the solution during reaction) in BLG, reduces the relative intensities of 2D and 2D1A, suggesting a different degree of change in the exchange phonon momentum between the two phonon branches during the second-order double resonance (DR) process.48 On the other hand, since the associated first-order DR process of BLG is activated by the formation of sp3 hybridization,48 it is reasonable that the D peak of BLG shares the same spectroscopic features as the 2D peak, as shown in Figure 2e. More detailed research to understand the phonon behavior in functionalized BLG using Raman spectroscopy is underway and will be published in a subsequent report.

For comparison, the same electron transfer chemistry in the absence of external electrochemical bias is capable of functionalizing MLG to ID/IG ∼ 2, which corresponds to V\text{RXN} of approximately 1.5 V in our method (see Figure 2a), but is unable to functionalize BLG to an observable degree as we have previously reported.33,34,36 However, the method developed in this work can readily functionalize BLG with V\text{RXN} ≥ 1 V, and the difference in reactivity between MLG and BLG is significantly diminished compared those reported.20,33,36 In this study, the highest degree of functionalization with ID/IG ∼ 2 is achieved using V\text{RXN} = 2.5 V. This is consistent with the previous observation that the reaction rate in an unbiased electron transfer reaction20,33,36 of MLG is dominated by the localized fluctuation of Fermi level caused by the underlying substrate,40 which is suppressed in BLG due to screening from an additional graphitic layer.34,51 Using our method, since we functionalize graphene by raising its Fermi level directly, the difference in reactivity between MLG and BLG is mainly determined by the relatively small difference of density of states (DOS) around the Dirac point.51 Note that it is expected that ID/IG for BLG is approximately half of that for MLG, since the former, as we observe, has an inaccessible graphene layer.

Electronic Transport in Functionalized MLG. To study the effect of chemical functionalization on the electronic transport in graphene, FET devices with various degrees of functionalization were prepared using the aforementioned method. Before electronic characterization, 20 Raman spectra were taken randomly in each sample to obtain an average ID/IG value. All devices were characterized at 14 K. The resistivity of MLG between the source and drain electrodes as a function of bottom gate (BG) voltage, V\text{BG}, for a pristine device, one with ID/IG = 1.4, and one with ID/IG = 4.6, are shown in Figure 3a. Each curve exhibits a clear maximum resistivity, R\text{max}, which
occurs where the Fermi level coincides with the Dirac point (the so-called charge neutrality point (CNP)), and the corresponding \( V_{BG} \) is \( V_{BG,CNP} \). In bottom-gated devices, the parallel-plate capacitor model yields a field-effect charge density \( n_{FE} = C_{BG}(V_{BG} - V_{BG,CNP}) \), where \( C_{BG} \) is the bottom-gate capacitance. Comparing to the pristine, unfunctionalized device, the functionalization introduces a positive shift in \( V_{BG,CNP} \), which corresponds to additional \( 5.21 \times 10^{11} \) (\( I_{D}/I_G = 1.4 \)) and \( 9.34 \times 10^{11} \) cm\(^{-2} \) (\( I_{D}/I_G = 4.6 \)) holes doped to the MLG devices. The p-type doping also hinders the electron conduction, which is associated with \( V_{BG} > V_{BG,CNP} \),\(^{7} \) such that electron–hole conduction asymmetry was observed in the samples with high \( I_{D}/I_G \).

The calculated field-effect hole mobilities, \( \mu_{FE} \), and the minimum conductivities, \( G_{min} = 1/\mu_{min} \) for several MLG devices as a function of the measured \( I_{D}/I_G \) values are shown in Figure 3b and c, respectively. Despite the fact that \( \mu_{FE} \) and \( G_{min} \) decrease exponentially with \( I_{D}/I_G \), the reduction rate of \( \mu_{FE} \) is found to be anomalously 100 times higher than that of \( G_{min} \).

The counterbalancing influences of scattering and doping, both of which are changed after chemical functionalization, are predicted in even a classical depiction of carrier transport. For example, the electronic conductivity in a solid can be described by the Drude-Lorentz model:\(^{52} \)

\[
G = \frac{n e^2 \Lambda}{m^* \nu_F} \tag{1}
\]

where \( G \) is the conductivity, \( n \) is the total charge density, \( e \) is the elementary charge, \( m^* \) is the effective mass of carriers, \( \Lambda \) is the mean free path of carriers, and \( \nu_F \) is the Fermi velocity. The mobility of carriers, \( \mu \), in a typical semiconductor is given by:\(^{52} \)

\[
\mu = \frac{e \Lambda}{m^* \nu_F} = \frac{G}{n e} \tag{2}
\]

In the specific case for the total charge density in MLG, \( n \) can be expressed as:

\[
n = n_{FE} + n \tag{3}
\]

where \( n \) is the charge density resulting from the formation of electron–hole puddles in graphene due to the charged impurities.\(^{53} \) While \( \mu_{FE} \) and \( G_{min} \) are compared at different charge densities in this work (and charge carriers in MLG mimic relativistic particles with zero mass in contrast to eq 2), eqs 1–3, illustrate the counterbalance between scattering and carrier doping. Specifically, the strong reduction of mobility with \( I_{D}/I_G \) implies that the structural defects generated during the functionalization process significantly mean free path from \( \sim 100 \) nm (pristine, \( \nu_F \sim 10^5 \) cm/s) to \( \sim 1 \) nm (\( I_{D}/I_G = \delta, \mu_{FE} \sim 10^5 \) cm/s). However, since \( G_{min} \) only weakly decreases with \( I_{D}/I_G \), it appears that the charge density, \( n \), in eq 1 increases significantly. At the CNP, where \( G_{min} \) is characterized, the electronic transport is dominated by the formation of electron–hole puddles, \( n_{FE} \), because \( n_{FE} \approx 0 \).\(^{53} \) This evidence clearly suggests that additional charge impurities, \( n \), are introduced due to chemical functionalization.

To obtain additional insight into the electronic band structure of functionalized MLG, we studied the temperature dependence of \( G_{min} \) in the range of 14–200 K. Figure 3d shows the measured \( G_{min} \) as a function of inverse temperature, \( 1/T \), for three different values of \( I_{D}/I_G \). We observe two distinct temperature regimes: a fast decrease of the conductivity from 200 to 100 K, followed by a much weaker temperature dependence from 100 to 14 K. For the temperatures considered, we found that the conductivity can be well-described by an activation model with two different activation energies:

\[
G_{min} = G_1 \exp \left( \frac{-E_1}{k_B T} \right) + G_2 \exp \left( \frac{-E_2}{k_B T} \right) \tag{4}
\]

where \( G \) is the conductivity, \( E \) is the activation energy, \( k_B \) is the Boltzmann constant, and the subscripts 1 and 2 correspond to the regimes of strong and weak temperature dependence, respectively. The temperature-dependent behavior was also observed in dual-gated BLG devices.\(^{10,11} \) The extracted activation energies, \( E_1 \) and \( E_2 \), are plotted versus the corresponding \( I_{D}/I_G \) in Figure 3e and f, respectively. The higher energy, \( E_1 \), corresponds to thermal excitation of carriers across the Dirac point,\(^{4} \) and only exhibits a weak dependence on \( I_{D}/I_G \). The temperature dependence in the high-temperature regime is not originated from the formation of band gap and has often been observed in high-quality graphene samples.\(^{7} \) On the other hand, the low energy, \( E_2 \), exhibits a linear dependence on \( I_{D}/I_G \) and is therefore possibly proportional to the effective transport band gap.\(^{10,11} \) Note that the weak temperature dependence of \( G_{min} \) in the low-temperature regime does not necessarily suggest the formation of transport band gap since the extracted values of \( E_2 \) are considerably smaller than \( k_B T \). Other transport mechanisms (e.g., variable range hopping)\(^{33} \) may also play an important role.

After covalent functionalization, the sp\(^2\) lattice is partially distorted and interspersed with sp\(^3\) regions (a schematic diagram of a functionalized MLG is shown in Figure 3g). Theoretically, there are two mechanisms underlying the formation of a band gap in covalently functionalized MLG: (i) a large band gap (\( \sim 1–2 \) eV predicted by DFT calculations)\(^{33} \) created around the structurally disordered region (S-region, see Figure 3g top)\(^{33} \) due to the sp\(^3\) hybridization, and (ii) a relatively small band gap (\( \sim 100 \) meV) created in the pristine sp\(^2\) lattice between two neighboring S-regions due to the quantum interference phenomena (see Figure 3g bottom). Based on the schematic shown in Figure 3g, we propose a model to estimate the transport band gap created in functionalized graphene. First, the experimentally measured \( I_{D}/I_G \) is empirically given by:\(^{43} \)

\[
\frac{I_D}{I_G} = \frac{102}{L_D^2} \tag{5}
\]

where \( L_D \) is the average distance (in units of nm) between the centers of the S-regions (see Figure 3g bottom). Equation 5 suggests that \( L_D > 4 \) nm for the degree of functionalization considered here. Since this value is much larger than the radius of the S-region, \( r_S (\sim 0.5 \) nm),\(^{41} \) it appears that the creation of a band gap in functionalized graphene is dominated by the quantum interference effect, and the sp\(^2\) lattice of graphene is mostly preserved after functionalization. Note that eq 5 was estimated in physically defective graphitic materials,\(^{48} \) while recent findings in covalently functionalized graphene suggest that the value of \( L_D \) may be smaller than 1 nm.\(^{52,53} \) To model the electronic transport through the “channels” between the S-regions, the following assumptions were made: (i) the S-region is electrically insulating; (ii) the radius of the S-region, \( r_S \), is much smaller than \( L_D \); and (iii) the edges of a conducting channel between two S-regions can be modeled approximately as either hydrogen-passivated armchair or zigzag conforma-
tions. Therefore, the local electronic transport in covalently functionalized MLG is analogous to that in a graphene nanoribbon (GNR)\textsuperscript{13} of width $L_D$. The local band gaps, $E_{G,\text{local}}$ corresponding to the armchair edges with dimer lines $N_a = 3p$, $3p + 1$, and $3p + 2$, where $p$ is an integer, are given by:\textsuperscript{13}

$$E_{G,\text{local}}^{3p} = \Delta_{3p}^0 - \frac{8\delta}{3p + 1} \sin^2 \left( \frac{p\pi}{3p + 1} \right)$$  \hspace{1cm} (6)

$$E_{G,\text{local}}^{3p+1} = \Delta_{3p+1}^0 + \frac{8\delta}{3p + 2} \sin^2 \left( \frac{(p + 1)\pi}{3p + 2} \right)$$  \hspace{1cm} (7)

$$E_{G,\text{local}}^{3p+2} = \frac{2\delta}{p + 1}$$  \hspace{1cm} (8)

where $\Delta_{3p}^0 = t[4 \cos(p\pi/(3p + 1)) - 2]$, $\Delta_{3p+1}^0 = t[2 - 4 \cos((p + 1)\pi/(3p + 2))]$, $t = 2.7$ eV, and $\delta = 0.12$.\textsuperscript{13} The channel width $L_D = 3^{1/2}(N_a - 1)\pi/2$, where $a = 1.42$ Å is the lattice parameter. The $E_{G,\text{local}}$ of zigzag edges is given by:\textsuperscript{13}

$$E_{G,\text{local}}^{\text{zigzag}} = \frac{9.33}{L_D + 15}$$  \hspace{1cm} (9)

Figure 3h shows the calculated $E_{G,\text{local}}$ and $L_D$ as a function of $I_D/I_G$ using eqs 5–9. The present model predicts the formation of a 50–300 meV local band gap in highly functionalized MLG ($I_D/I_G \sim 5$), which is approximately 3 orders of magnitude larger than the effective transport band gap, $E_t$ (see Figure 3f).

The findings support the influence of disorder.\textsuperscript{10,11} In pristine MLG, charges and impurities have been proposed to be the dominant sources of scattering.\textsuperscript{33,54} The impurities affect the electric potential experienced and result in the formation of electron–hole puddles\textsuperscript{55} and localized trap states near the Dirac point.\textsuperscript{55} The density of states near the Dirac point in bulk MLG is therefore increased. In functionalized MLG, as shown in Figure 3i, although ideally a local band gap, $E_{G,\text{local}}$ is created due to the quantum interference effect, a significant amount of disorder, including impurities and the grafted functional groups, is induced on the graphene surface during functionalization, such that numerous midgap states are generated.\textsuperscript{55} Moreover, considering the effects of a spatially inhomogeneous distribution of $L_D$ and Fermi level, it is not surprising that the effective transport band gap, $E_t$, in bulk MLG is greatly reduced. Since the formation of midgap states also introduces additional charges near the Dirac point, it also explains why the obtained $G_{\text{min}}$ only decreases weakly with $I_D/I_G$. Hence, it is not strictly appropriate to apply the activated model in eq 4 for $E_t$ values that are exceedingly small as measured in this work. In this case, the interpretation is instead that of an effective activation barrier compromised via disorder induced midgap states, analogous to an effective activation energy in chemical kinetics. In the limit as the purity of graphene and its environment increase, this effective barrier converges to the transport band gap.

Measurements of the conductivity, $G$, of a highly functionalized MLG device ($I_D/I_G = 4.6$) as a function of drain-source voltage, $V_{DS}$, and ($V_{BG} - V_{BG,CNP}$) are shown in Figure 4a. At the CNP ($V_{BG} - V_{BG,CNP} = 0$), we did not observe any $V_{DS}$-dependent behavior. Hence, the transport band gap is not detectable, since the effective transport gap (see Figure 3f) is much smaller than the value of $k_BT$ at 14 K. To further elucidate the role of disorder in electronic transport, the functionalized MLG device was suspended using the method proposed by Bolotin et al.\textsuperscript{3} Briefly, the device on SiO$_2$ was immersed in 7:1 buffered oxide etch for 90 s, which etches away approximately 50% of the SiO$_2$, including the area under the graphene.\textsuperscript{3} Figure 4b shows the obtained values of $G$ as a function of $V_{DS}$ and ($V_{BG} - V_{BG,CNP}$) for a highly functionalized MLG device ($I_D/I_G = 4.6$) (a) before and (b) after suspension.

**Figure 4.** Measured conductivities as a function of $V_{DS}$ and ($V_{BG} - V_{BG,CNP}$) for a highly functionalized MLG device ($I_D/I_G = 4.6$) (a) before and (b) after suspension.
top-gate voltages at a specific CNP, where the value of $R_{\text{max}}$ reaches its minimum for a standard BLG device. Figure 5c shows the measured values of $V_{\text{BG}}$ and $V_{\text{TG}}$ of a BLG device at various CNPs. Note that $V_{\text{BG}}$ and $V_{\text{TG}}$ are linearly related with a slope of $-\left(C_{\text{BG}}/C_{\text{TG}}\right)$. To normalize the top- and bottom-gate electric fields, following the convention proposed by Zhang et al., we define the bottom-gated and top-gated electric displacement fields using $D_{\text{BG}} = \epsilon_{\text{BG}}(V_{\text{BG}} - V_{\text{D}})/d_{\text{BG}}$ and $D_{\text{TG}} = \epsilon_{\text{TG}}(V_{\text{TG}} - V_{\text{D}})/d_{\text{TG}}$, where $\epsilon$ is the permittivity and $d$ is the thickness of gate dielectric. The average electric displacement field is therefore given by: $D = (D_{\text{BG}} - D_{\text{TG}})/2$. As mentioned before, in the absence of gating ($D = 0$), the conduction and valence bands of BLG touch one another with zero band gap. Upon electrical gating, the average electrical displacement field, $|D|$, breaks the inversion symmetry of BLG and generates a nonzero band gap.

Using the defined electric displacement fields, the resistivities of BLG as a function of $D_{\text{BG}}$ and $D_{\text{TG}}$ for pristine, $I_\text{D}/I_\text{G} = 0.8$, and $I_\text{D}/I_\text{G} = 1.8$ devices are shown in Figure 5d–f, respectively. For each contour, we observe a rise of resistivity with $|D|$ along the diagonal, corresponding to the trajectory of CNPs, representing the signature behavior of a dual-gated BLG device. The electronic transport in functionalized bilayer graphene still exhibits a strong dependence on the transverse electric displacement field, and the characteristics associated with the symmetry breaking at a high transverse electric displacement field are preserved. Quite surprisingly, we find that even the highest degree of functionalization considered ($I_\text{D}/I_\text{G} = 1.8$) does not undermine the lattice structure of AB-stacked BLG, so the symmetry breaking still dominates the transport in functionalized BLG. However, similar to the transport in functionalized MLG, because theoretically an $\sim 1$ eV band gap can be created locally in the S-region due to the grafted functional groups on the top graphitic layer, we expect that the quantum interference effect also plays an important role depending on the degree of functionalization. The formation of a transport band gap in a dual-gated, functionalized BLG device likely results from the effects of symmetry breaking and quantum interference.

To uncover the relation between the symmetry breaking and the quantum interference effects in functionalized BLG, the resistivities for the three BLG devices considered under $D_{\text{BG}} = 0$ V/nm and $D_{\text{BG}} = 1.4$ V/nm. (i) $R_{\text{max}}$ as a function of $D$ for the three BLG devices considered.
The transport characteristics of functionalized BLG (Figure 5g) are similar to those of the bottom-gated MLG devices (see Figure 3a). The slow increase of $R_{\text{max}}$ with $I_D/I_G$ suggests that the electronic transport in functionalized BLG is disorder-limited, although a band gap is created locally. However, under a positive electrical displacement field $D_{\text{BLG}} = 1.4$ V/nm (Figure 5h), the $R_{\text{max}}$ value increases significantly with $I_D/I_G$ and the on/off current ratio increases by 50%. The measured values of $R_{\text{max}}$ along the trajectory of CNPs as a function of $D$ for the three BLG devices considered here are shown in Figure 5i. In pristine BLG, $R_{\text{max}}$ is almost symmetric with respect to $D = 0$; however, a significant asymmetry is induced by the chemical functionalization. Interestingly, for $D < 0$, the three curves are almost parallel, while a drastic increase of $R_{\text{max}}$ is observed at high $D$. We believe that this implies the formation of a larger transport band gap due to the complicated interactions between the effects of chemical doping, disorder, symmetry breaking, and quantum interference. A future study will attempt to gain a better understanding of the electronic transport in this regime.

**Conclusion.** In conclusion, we have demonstrated an efficient method to covalently functionalize MLG and BLG in a precise and controllable manner using an electrochemical azo dianion chemistry. Using this method, for the first time, we have studied the transport characteristics of bottom-gated MLG and dual-gated BLG FET devices as a function of $I_D/I_G$ which provides insight on the electronic transport in functionalized graphene. We have shown that the electronic transport in functionalized graphene is limited by the formation of electron-hole puddles and midgap states due to chemical functionalization. The effective transport band gap is typically three orders of magnitude smaller than that predicted by the theory. A more significant transport band gap can be created in functionalized BLG at a highly positive transverse electric displacement field.

**REFERENCES**


**ASSOCIATED CONTENT**

Supporting Information

Additional experimental details regarding device fabrication and characterization. This material is available free of charge via the Internet at http://pubs.acs.org.

**AUTHOR INFORMATION**

Corresponding Author

*E-mail: strano@mit.edu.

Notes

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